



Metra utilizes for factory calibration a modern PC based calibration system. The calibration procedure is based on a transfer standard which is regularly sent to Physikalisch-Technische Bundesanstalt (PTB) for recalibration.

Metra sensors, with few exceptions, are supplied with an individual calibration chart (Figure 1). It shows all individual-measured data like sensitivity, transverse sensitivity, insulation resistance, IEPE bias voltage and frequency response curve. Additionally, all available typical characteristics for the transducer are listed.

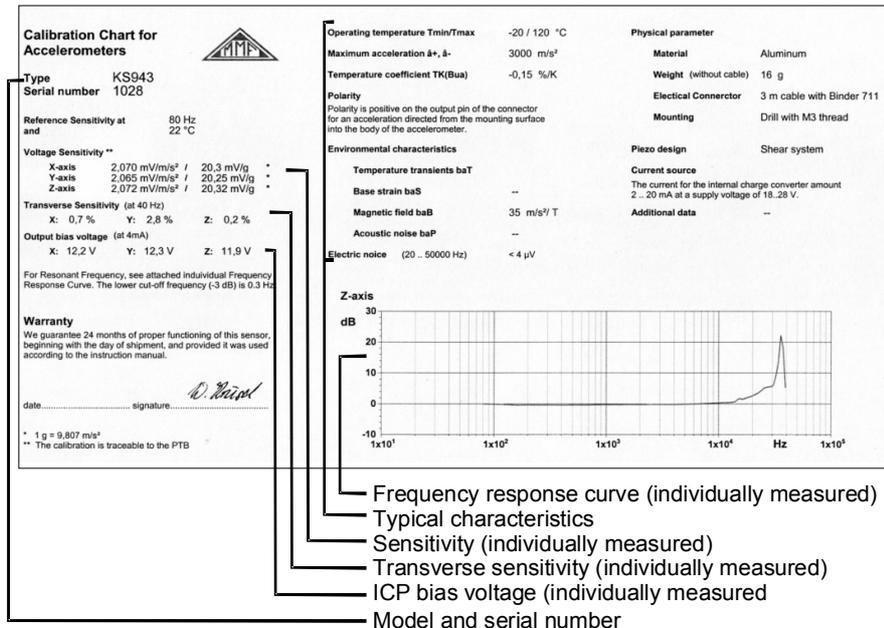


Figure 1: Individual calibration chart of Metra accelerometers

The following sections explain the parameters used in the individual calibration sheets.

## Sensitivity

A piezoelectric accelerometer with charge output can be regarded as either a charge source or a voltage source with very high impedance. Consequently, charge sensitivity or voltage sensitivity are used to describe the relationship between acceleration and output. In the individual characteristics sheet Metra states the charge sensitivity at 80 Hz and room temperature in picocoulombs per g or per ms<sup>-2</sup> (1 g = 9.81 m/s<sup>2</sup>).

The sensitivity of accelerometers with IEPE output is stated as voltage sensitivity in millivolts per g or per ms<sup>-2</sup>.

The total accuracy of this calibration is 2 %, valid under the following conditions:

$$f = 80 \text{ Hz}, T = 21 \text{ °C}, a = 10 \text{ m/s}^2, C_{\text{CABLE}} = 150 \text{ pF}, I_{\text{CONST}} = 4 \text{ mA}.$$

The stated accuracy should not be confused with the tolerance of nominal sensitivity which is specified for some accelerometers. Model KS80, for instance, has  $\pm 5 \%$  nominal sensitivity tolerance. Standard tolerance window for sensitivity, if not otherwise stated, is  $\pm 20 \%$ . Hence the exact sensitivity of production accelerometers may vary from the nominal sensitivity within the specified tolerance range.

Charge sensitivity decreases slightly with increasing frequency. It drops about 2 % per decade. For precise measurements at frequencies differing very much from 80 Hz a recalibration in the desired frequency range should be performed.

Before leaving the factory each accelerometer undergoes a thorough artificial aging process. Nevertheless, further natural aging can not be avoided completely. Typical are -3 % sensitivity loss within the first 3 years. For a high degree of accuracy recalibration should be performed (see Application Note AN10E).



## Frequency Response

Measurement of frequency response requires mechanical excitation of the transducer. Metra uses an especially-designed calibration shaker which is driven by a sine-wave generator swept over a frequency range from 20 or 80 Hz to 40 000 Hz. Acceleration is kept nearly constant at  $3 \text{ m/s}^2$  over the entire frequency range by means of a feedback signal from a reference accelerometer. Most accelerometers are supplied with an individual frequency response curve. It shows the deviation of sensitivity in dB. For example the upper 3 dB limit can be derived from this curve. The 3 dB limit is often used in scientific specifications. It marks the frequency where the measuring error becomes 30 %. It is usually at about 50 % of the resonance frequency (compare Application Note AN2E, Figure 3). The 1 dB limit marks an error of approximately 10 %. It can be found in the range of 1/3 the resonance frequency. The mounted resonance frequency, which is the largest mechanical resonance, can be identified as well from this curve. Often there are sub-resonances present at lower frequencies. Metra performs frequency response measurements under optimum operating conditions with the best possible contact between accelerometer and vibration source practical. In practice, mounting conditions will be less than ideal in many cases and often a lower resonance frequency will be obtained.

The frequency response of IEPE transducers can be affected by long cables (see section Application Note AN4E).

## Transverse Sensitivity

Transverse sensitivity is the ratio of the output due to acceleration applied perpendicular to the sensitive axis divided by the basic sensitivity in the main direction. The measurement is made at 40 Hz sine excitation rotating the sensor around a vertical axis. A figure-eight curve is obtained for transversal sensitivity. Its maximum deflection is the stated value. Typical are <5 % for shear accelerometers and <10 % for compression and bender models.

## Maximum Acceleration

Usually the following limits are specified:

- $\hat{a}_+$  maximum acceleration for positive output direction
- $\hat{a}_-$  maximum acceleration for negative output direction
- $\hat{a}_q$  maximum acceleration for transversal direction (only for shock accelerometers)

The maximum acceleration is given for frequencies within the operating frequency range and at room temperature. At higher temperatures it may be lower.

For charge output accelerometers these limits are determined solely by the sensor's construction. If one of these limits is exceeded accidentally, for example, by dropping the sensor on the ground, the sensor will usually still function.

However, we recommend recalibrating the accelerometer after such incidents. Continuous vibration should not exceed 25 % of the stated limits to avoid wear. When highest accuracy is required, acceleration should not be higher than 10 % of the limit. Transducers with extremely high maximum acceleration are called shock accelerometers, for example Model KD93 with  $\hat{a}=100\,000 \text{ m/s}^2$ .

If the accelerometer is equipped with built-in IEPE electronics, the limits  $\hat{a}_+$  and  $\hat{a}_-$  are usually determined by the output voltage span of the amplifier (see section ).



## Operating Temperature Range

The maximum operating temperature of a charge transducer is limited by the piezoelectric material. Above a specified temperature, called Curie point, the piezoelectric element will begin to depolarize causing a permanent loss in sensitivity. The specified maximum operating temperature is the limit at which the permanent change of sensitivity is 3 %. Other components may also limit the operating temperature, for example, adhesives, resins or built-in electronics. Typical temperature ranges are -35 to 150 °C and -10 to 80 °C. Accelerometers with built-in electronics are generally not suitable for temperatures above 120 °C.

## Temperature Coefficients

Apart from permanent changes, some characteristics vary over the operating temperature range. Temperature coefficients are specified for charge sensitivity (TK(B<sub>qa</sub>)) and inner capacitance (TK(C<sub>i</sub>)). For sensors with built-in electronics only the temperature coefficient of voltage sensitivity TK(B<sub>ua</sub>) is stated.

There is a simple way to reduce the temperature coefficient of charge mode accelerometers. Since the temperature coefficients of B<sub>qa</sub>, B<sub>ua</sub> and C<sub>i</sub> are different, the temperature behavior can be compensated by a serial capacitor at charge amplification or a parallel capacitor in case of high impedance voltage amplification. This capacitor is calculated to:

$$C = C_i \frac{TK(C_i) - TK(B_{qa})}{TK(B_{ua})}$$

This can be a useful improvement in case of very changeable temperatures. Please consider, that the total sensitivity will become lower by this measure.

## Temperature Transients

In addition to the temperature characteristics mentioned above, accelerometers exhibit a slowly varying output when subjected to temperature transients, caused by so-called pyroelectric effect. This is specified by temperature transient sensitivity b<sub>aT</sub>. Temperature transient errors have frequencies below 10 Hz. Where low frequency measurements are made this effect must be considered. To avoid this problem, shear type accelerometers should be chosen for low frequency measurements. In practice, they are approximately 100 times less sensitive to temperature transients than compression sensors. Bender systems are midway between the other two systems in terms of sensitivity to temperature transients. When compression sensors are used the amplifier should be adjusted to a 3 or 10 Hz lower frequency limit.

## Base Strain

When an accelerometer is mounted on a structure which is subjected to strain variations, an unwanted output may be generated as a result of strain transmitted to the piezoelectric material. This effect can be described as base strain sensitivity b<sub>as</sub>. The stated values are determined by means of a bending beam oscillating at 8 or 15 Hz. Base strain output usually occurs at frequencies below 500 Hz. Shear type accelerometers have extremely low base strain sensitivity and should be chosen for strain-critical applications.

## Magnetic Fields

Strong magnetic fields often occur around electric machines at 50 Hz and multiples. Magnetic field sensitivity  $b_{AB}$  has been measured at  $B=0.01$  T and 50 Hz for some accelerometers. It is very low and can be ignored under normal conditions.

Generally, accelerometers with stainless steel cases provide better protection against magnetic fields than accelerometers with aluminum cases.

Stray signal pickup can be avoided by proper cable shielding. This is of particular importance for sensors with charge output.

Adequate isolation must be provided against ground loops. They can occur when a measuring system is grounded at several points, particularly when the distance between these grounding points is long. Ground loops can be avoided using accelerometers with insulated bases (for instance Models KS74 and KS80) or insulating mounting studs. More about ground loops can be found in Application Note AN9).

## Acoustic Noise

If an accelerometer is exposed to a very high noise level, a deformation of the sensor case may occur which can be measured as an output under extreme conditions. Acoustic noise sensitivity  $b_{ap}$  as stated for some models is measured at an SPL of 154 dB which is beyond the pain barrier of the human ear. Acoustic noise sensitivity should not be confused with the sensor response to pressure induced motion of the structure on which it is mounted.

## Intrinsic Noise and Resolution

A piezoelectric sensing element can be regarded as purely capacitive source. Therefore, the sensor itself is free of intrinsic noise. The only noise contribution is caused by the temperature motion of electrons in the built-in the IEPE charge converter. Consequently, a noise specification makes only sense for IEPE sensors.

The intrinsic noise of IEPE accelerometers mainly depends on the frequency.

Below about 100 Hz it has the typical  $1/f$  characteristics. Above 100 Hz the noise level is nearly independent of the frequency. The following picture shows a typical noise spectrum of an IEPE accelerometer:

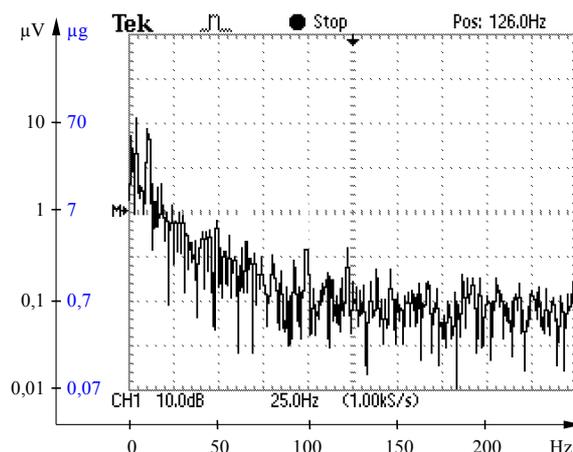


Figure 2: Typical noise spectrum of an IEPE accelerometer



It is useful to state the noise of an accelerometer as equivalent acceleration level. For this purpose, the noise voltage ( $u_n$ ) is divided by transducer sensitivity ( $B_{ua}$ ) yielding the equivalent noise acceleration ( $a_n$ ):

$$a_n = \frac{u_n}{B_{ua}}$$

While  $u_n$  only depends on the electronic circuit which is similar for all sensor types, the sensitivity of the piezoelectric sensing element will directly influence the equivalent noise acceleration. It can be seen that a transducer equipped with a very sensitive piezo system provides a very good resolution.

The characteristics of most accelerometers show noise accelerations for several frequencies.

Example for a noise statement:

1 Hz:	70 $\mu$ g
10 Hz:	7 $\mu$ g
100 Hz:	2 $\mu$ g

The intrinsic noise determines the resolution limit of the sensor. Signals below the noise level cannot be measured.

The **detection limit** to DIN 45661 is the RMS of acceleration where the sensor output is two times the RMS of the noise voltage.

The **signal-to-noise-ratio**  $S_n$  is a measure of the error caused by noise. It is the logarithm of the ratio of the measured signal level ( $u$ ) and the noise level ( $u_n$ ):

$$S_n = 20 \log \frac{u}{u_n}$$

For the evaluation of the intrinsic noise of an entire measuring chain the noise of all components including signal conditioners and other instruments has to be considered.

## Inner Capacitance

The inner capacitance is stated in the individual calibration sheet only for accelerometers with charge output. It can be relevant if the transducer is used with a high impedance voltage amplifier (compare Application Note AN6E). The given value includes the capacitance of the sensor cable which was used for calibration. This cable capacitance is stated separately in the calibration sheet. Its value has to be deducted from the sensor capacitance to obtain the actual inner capacitance.



## Protection Grades

The IP protection grades to DIN 40050 characterize the suitability of a product for given environmental conditions. The first digit of the IP number means the shielding from the insertion of objects and dust. The second digit marks the protection against humidity.

Number	First Digit	Second Digit
0	No protection against hand or body contact	No protection
1	Maximum object dimension which can be inserted is 50 mm	Equipment is protected against vertical drops fall
2	Maximum object dimension which can be inserted is 12 mm	Equipment is protected against drops falling with 15° slope regarding the vertical axis
3	Maximum object dimension which can be inserted is 2.5 mm	Equipment is protected against drops falling with 60° slope regarding the vertical axis
4	Maximum object dimension which can be inserted is 1 mm	Equipment is protected against splashing water coming from any direction
5	Inserted dust may not overlay equipment parts	Equipment is protected against water jets coming from any direction
6	Full protection against dust insertion	Equipment is protected against powerful water jets
7	-	Equipment is protected against temporary immersion for a given time duration
8	-	Equipment is protected against permanent immersion with given pressure